## - Bus Transceivers/Registers

- Independent Registers and Enables for A and B Buses
- Multiplexed Real-Time and Stored Data
- Choice of True or Inverting Data Paths
- Choice of 3-State or Open-Collector Outputs to A Bus

| DEVICE | A OUTPUT | B OUTPUT | LOGIC |
| :---: | :---: | :---: | :---: |
| SN74ALS651A, <br> 'AS651 | 3-State | 3-State | Inverting |
| SN54ALS652, <br> SN74ALS652A, <br> 'AS652 | 3-State | 3-State | True |
| 'ALS653 | Open Collector | 3-State | Inverting |
| SN74ALS654 | Open Collector | 3-State | True |

## description

These devices consist of bus-transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers. Output-enable (OEAB and OEBA) inputs are provided to control the transceiver functions. Select-control (SAB and SBA) inputs are provided to select real-time or stored data transfer. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between stored and real-time data. A low input level selects real-time data, and a high input level selects stored data. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the octal bus transceivers and registers

SN54ALS', SN54AS' . . . JT PACKAGE
SN74ALS', SN74AS' . . . DW OR NT PACKAGE
(TOP VIEW)


SN54ALS', SN54AS' . . FK PACKAGE (TOP VIEW)


NC - No internal connection

Data on the A or B data bus, or both, can be stored in the internal D-type flip-flops by low-to-high transitions at the appropriate clock (CLKAB or CLKBA) terminals, regardless of the select- or output-control terminals. When SAB and SBA are in the real-time transfer mode, it is possible to store data without using the internal D-type flip-flops by simultaneously enabling OEAB and OEBA. In this configuration, each output reinforces its input. When all other data sources to the two sets of bus lines are at high impedance, each set of bus lines remains at its last state.
The - 1 versions of the SN74ALS651A and SN74ALS652A are identical to the standard versions except that the recommended maximum $\mathrm{I}_{\mathrm{OL}}$ for the -1 versions is increased to 48 mA . There are no -1 versions of the SN54ALS652, SN54ALS653, SN74ALS653, and SN74ALS654.

Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

## ORDERING INFORMATION

| TA | PACKAGE $\dagger$ |  | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
| :---: | :---: | :---: | :---: | :---: |
| $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$ | PDIP - NT | Tube | SN74ALS651ANT | SN74ALS651ANT |
|  |  |  | SN74ALS652ANT | SN74ALS652ANT |
|  |  |  | SN74ALS653NT | SN74ALS653NT |
|  |  |  | SN74ALS654NT | SN74ALS654NT |
|  |  |  | SN74AS651NT | SN74AS651NT |
|  |  |  | SN74AS652NT | SN74AS652NT |
|  | SOIC - DW | Tube | SN74ALS651ADW | ALS651A |
|  |  | Tape and reel | SN74ALS651ADWR |  |
|  |  | Tube | SN74ALS652ADW | ALS652A |
|  |  | Tape and reel | SN74ALS652ADWR |  |
|  |  | Tube | SN74ALS653DW | ALS653 |
|  |  | Tape and reel | SN74ALS653DWR |  |
|  |  | Tube | SN74ALS654DW | ALS654 |
|  |  | Tape and reel | SN74ALS654DWR |  |
|  |  | Tube | SN74AS651DW | AS651 |
|  |  | Tape and reel | SN74AS651DWR |  |
|  |  | Tube | SN74AS652DW | AS652 |
|  |  | Tape and reel | SN74AS652DWR |  |
| $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$ | CDIP - JT | Tube | SNJ54ALS652JT | SNJ54ALS652JT |
|  |  |  | SNJ54ALS653JT | SNJ54ALS653JT |
|  |  |  | SNJ54AS651JT | SNJ54AS651JT |
|  |  |  | SNJ54AS652JT | SNJ54AS652JT |
|  | LCCC - FK | Tube | SNJ54ALS652FK | SNJ54ALS652FK |
|  |  |  | SNJ54ALS653FK | SNJ54ALS653FK |
|  |  |  | SNJ54AS651FK | SNJ54AS651FK |
|  |  |  | SNJ54AS652FK | SNJ54AS652FK |

$\dagger$ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.


Pin numbers shown are for the DW, JT, and NT packages.
Figure 1. Bus-Management Functions

SN54ALS653, SN54AS651,
SN74ALS651A, SN74ALS653, SN74AS651

| INPUTS |  |  |  |  |  | DATA I/O $\dagger$ |  | OPERATION OR FUNCTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OEAB | $\overline{\text { OEBA }}$ | CLKAB | CLKBA | SAB | SBA | A1-A8 | B1-B8 |  |
| L | H | H or L | H or L | X | X | Input | Input | Isolation |
| L | H | $\uparrow$ | $\uparrow$ | X | X | Input | Input | Store $A$ and $B$ data |
| X | H | $\uparrow$ | H or L | X | X | Input | Unspecified $\ddagger$ | Store A, hold B |
| H | H | $\uparrow$ | $\uparrow$ | X $\ddagger$ | X | Input | Output | Store A in both registers |
| L | X | H or L | $\uparrow$ | X | X | Unspecified $\ddagger$ | Input | Hold A, store B |
| L | L | $\uparrow$ | $\uparrow$ | X | X $\ddagger$ | Output | Input | Store B in both registers |
| L | L | X | X | X | L | Output | Input | Real-time $\bar{B}$ data to $A$ bus |
| L | L | X | H or L | X | H | Output | Input | Stored $\overline{\mathrm{B}}$ data to A bus |
| H | H | X | X | L | X | Input | Output | Real-time $\bar{A}$ data to $B$ bus |
| H | H | H or L | X | H | X |  | Output | Stored $\bar{A}$ data to $B$ bus |
| H | L | H or L | H or L | H | H | Output | Output | Stored $\bar{A}$ data to $B$ bus and stored $\bar{B}$ data to $A$ bus |

$\dagger$ The data output functions can be enabled or disabled by a variety of level combinations at OEAB or $\overline{\mathrm{OEBA}}$. Data input functions always are enabled; i.e., data at the bus terminals is stored on every low-to-high transition on the clock inputs.
$\ddagger$ Select control = L: clocks can occur simultaneously.
Select control = H: clocks must be staggered to load both registers.

SN54ALS652, SN54AS652,
SN74ALS652A, SN74ALS654, SN74AS652

| INPUTS |  |  |  |  |  | DATA I/O $\dagger$ |  | OPERATION OR FUNCTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OEAB | $\overline{\text { OEBA }}$ | CLKAB | CLKBA | SAB | SBA | A1-A8 | B1-B8 |  |
| L | H | H or L | H or L | X | X | Input | Input | Isolation |
| L | H | $\uparrow$ | $\uparrow$ | X | X | Input | Input | Store A and B data |
| X | H | $\uparrow$ | H or L | X | X | Input | Unspecified $\ddagger$ | Store A, hold B |
| H | H | $\uparrow$ | $\uparrow$ | X $\ddagger$ | X | Input | Output | Store A in both registers |
| L | X | H or L | $\uparrow$ | X | X | Unspecified $\ddagger$ | Input | Hold A, store B |
| L | L | $\uparrow$ | $\uparrow$ | X | X $\ddagger$ | Output | Input | Store B in both registers |
| L | L | X | X | X | L | Output | Input | Real-time $B$ data to $A$ bus |
| L | L | X | H or L | X | H | Output | Input | Stored $B$ data to $A$ bus |
| H | H | X | X | L | X | Input | Output | Real-time $A$ data to $B$ bus |
| H | H | H or L | X | H | X | Input | Output | Stored $A$ data to $B$ bus |
| H | L | H or L | H or L | H | H | Output | Output | Stored $A$ data to $B$ bus and stored $B$ data to $A$ bus |

$\dagger$ The data output functions can be enabled or disabled by a variety of level combinations at OEAB or $\overline{\mathrm{OEBA}}$. Data input functions always are enabled; i.e., data at the bus terminals is stored on every low-to-high transition on the clock inputs.
$\ddagger$ Select control = L: clocks can occur simultaneously.
Select control = H: clocks must be staggered to load both registers.

## logic symbols $\dagger$



SN54ALS653, SN74ALS653


SN54ALS652, SN54AS652, SN74ALS652A, SN74AS652



SN74ALS654

$\dagger$ These symbols are in accordance with ANSIIIEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the DW, JT, and NT packages.

## logic diagrams (positive logic)



Pin numbers shown are for the DW, JT, and NT packages.

# SN54ALS652, SN54ALS653, SN54AS651, SN54AS652 SN74ALS651A, SN74ALS652A, SN74ALS653, SN74ALS654, SN74AS651, SN74AS652 OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS 

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

Supply voltage range, $\mathrm{V}_{\mathrm{CC}}$ -0.5 V to 7 V Input voltage range, $\mathrm{V}_{\mathrm{I}}$ : Control inputs -0.5 V to 7 V
I/O ports . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . -0.5 V to 5.5 V
Package thermal impedance, $\theta_{\text {JA }}$ (see Note 1): DW package . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 46²C/W
NT package . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . $67^{\circ} \mathrm{C} / \mathrm{W}$

$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.
recommended operating conditions

$\ddagger$ Applies only to the SN74ALS651A-1 and only if $\mathrm{V}_{\mathrm{CC}}$ is maintained between 4.75 V and 5.25 V
recommended operating conditions


[^0]electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | SN74ALS651A |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYP† | MAX |  |
| VIK |  |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $1 \mathrm{l}=-18 \mathrm{~mA}$ |  |  | -1.2 | V |
| VOH |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to 5.5 V , | $\mathrm{IOH}=-0.4 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{CC}}-2$ |  |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{IOH}=-3 \mathrm{~mA}$ | 2.4 | 3.2 |  |  |
|  |  | $\mathrm{I} \mathrm{OH}=-15 \mathrm{~mA}$ | 2 |  |  |  |
| VOL |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{IOL}=12 \mathrm{~mA}$ |  | 0.25 | 0.4 | V |
|  |  | $\mathrm{IOL}=24 \mathrm{~mA}$ |  |  | 0.35 | 0.5 |  |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}$, | $\mathrm{IOL}=48 \mathrm{~mA}$ (-1 versions) |  | 0.35 | 0.5 |  |  |
| $!$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=7 \mathrm{~V}$ |  |  | 0.1 | mA |  |
|  | A or B ports | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=5.5 \mathrm{~V}$ |  |  | 0.1 |  |  |
| $\mathrm{IIH}^{\text {H }}$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}=2.7 \mathrm{~V}$ |  |  | 20 | $\mu \mathrm{A}$ |  |
|  | A or B ports $\ddagger$ |  |  |  |  | 20 |  |  |
| IIL | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=0.4 \mathrm{~V}$ |  |  | -0.2 | mA |  |
|  | A or B ports $\ddagger$ |  |  |  |  | -0.2 |  |  |
| IO§ |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -30 |  | -112 | mA |  |
| ICC |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ | Outputs high |  | 42 | 68 | mA |  |
|  |  | Outputs low |  | 52 | 82 |  |  |
|  |  | Outputs disabled |  | 52 | 82 |  |  |

[^1]$\ddagger$ For I/O ports, the parameters $\mathrm{I}_{\mathrm{IH}}$ and $\mathrm{I}_{\mathrm{IL}}$ include the off-state output current.
§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | SN54ALS652 |  |  | SN74ALS652A |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYP $\dagger$ | MAX | MIN | TYP $\dagger$ | MAX |  |
| $\mathrm{V}_{\text {IK }}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}_{\mathrm{I}}=-18 \mathrm{~mA}$ |  |  | -1.2 |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to $5.5 \mathrm{~V}, \quad \mathrm{OH}=-0.4 \mathrm{~mA}$ |  | $\mathrm{V}_{\mathrm{CC}}{ }^{-2}$ |  |  | $\mathrm{V}_{\mathrm{CC}}{ }^{-2}$ |  |  | v |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{OH}=-3 \mathrm{~mA}$ | 2.4 | 3.2 |  | 2.4 | 3.2 |  |  |
|  |  | $\mathrm{I}^{\mathrm{OH}}=-12 \mathrm{~mA}$ | 2 |  |  |  |  |  |  |
|  |  | $\mathrm{I}^{\mathrm{OH}}=-15 \mathrm{~mA}$ |  |  |  | 2 |  |  |  |
| VOL |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{IOL}=12 \mathrm{~mA}$ |  | 0.25 | 0.4 |  | 0.25 | 0.4 | v |
|  |  | $\mathrm{IOL}=24 \mathrm{~mA}$ |  |  |  |  |  | 0.35 | 0.5 |  |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.75 \mathrm{~V}, \quad \mathrm{IOL}=48 \mathrm{~mA}$ (-1 versions) |  |  |  |  | 0.35 | 0.5 |  |  |
| 1 | Control inputs |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{1}=7 \mathrm{~V}$ | 0.1 |  |  | 0.1 |  |  | mA |
|  | A or B ports | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=5.5 \mathrm{~V}$ |  |  | 0.1 |  |  | 0.1 |  |  |
| $\mathrm{IIH}^{\text {H }}$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=2.7 \mathrm{~V}$ |  |  | 20 |  |  | 20 | $\mu \mathrm{A}$ |  |
|  | A or B ports $\ddagger$ |  |  |  |  | 20 |  |  | 20 |  |  |
| IIL | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=0.4 \mathrm{~V}$ |  |  | -0.2 |  |  | -0.2 | mA |  |
|  | A or B ports $\ddagger$ |  |  |  |  | -0.2 |  |  | -0.2 |  |  |
| 10 § |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -20 |  | -112 | -30 |  | -112 | mA |  |
| ICC |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ | Outputs high |  | 47 | 76 |  | 47 | 76 | mA |  |
|  |  | Outputs low |  | 55 | 88 |  | 55 | 88 |  |  |
|  |  | Outputs disabled |  | 55 | 88 |  | 55 | 88 |  |  |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ For I/O ports, the parameters $\mathrm{I}_{\mathrm{IH}}$ and $\mathrm{I}_{\mathrm{IL}}$ include the off-state output current.
§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.

## switching characteristics (see Figure 2)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R} 1=500 \Omega, \\ & \mathrm{R} 2=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAXt } \\ & \hline \end{aligned}$ |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN74 | 651A |  |
|  |  |  | MIN | MAX |  |
| ${ }_{\text {f max }}$ |  |  | 40 |  | MHz |
| tPLH | CLKBA or CLKAB | A or B | 8 | 32 | ns |
| tPHL |  |  | 5 | 17 |  |
| tPLH | A or B | B or A | 2 | 18 | ns |
| tpHL |  |  | 2 | 10 |  |
| tPLH | SBA or SAB $\ddagger$ (with A or B high) | A or B | 8 | 38 | ns |
| tPHL |  |  | 6 | 21 |  |
| tPLH | SBA or SAB $\ddagger$ (with A or B low) | A or B | 8 | 25 | ns |
| tPHL |  |  | 7 | 21 |  |
| tPZH | $\overline{\text { OEBA }}$ | A | 3 | 20 | ns |
| tPZL |  |  | 5 | 18 |  |
| tPHZ | $\overline{O E B A}$ | A | 2 | 9 | ns |
| tpLZ |  |  | 3 | 12 |  |
| tPZH | OEAB | B | 3 | 22 | ns |
| tpZL |  |  | 6 | 21 |  |
| tPHZ | OEAB | B | 2 | 12 | ns |
| tplZ |  |  | 2 | 14 |  |

$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
$\ddagger$ These parameters are measured with the internal output state of the storage register opposite that of the bus input.
switching characteristics (see Figure 2)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R} 1=500 \Omega, \\ & \mathrm{R} 2=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAXt } \end{aligned}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54ALS652 |  | SN74ALS652A |  |  |
|  |  |  | MIN | MAX | MIN | MAX |  |
| ${ }_{\text {max }}$ |  |  | 35 |  | 40 |  | MHz |
| tPLH | CLKBA or CLKAB | A or B | 10 | 35 | 8 | 30 | ns |
| tPHL |  |  | 5 | 20 | 5 | 17 |  |
| tPLH | A or B | B or A | 5 | 20 | 4 | 18 | ns |
| tPHL |  |  | 3 | 15 | 3 | 12 |  |
| tPLH | SBA or SAB $\ddagger$ (with A or B high) | A or B | 15 | 40 | 8 | 35 | ns |
| tPHL |  |  | 6 | 23 | 6 | 20 |  |
| tPLH | SBA or SAB $\ddagger$ (with A or B low) | A or B | 8 | 30 | 8 | 25 | ns |
| tPHL |  |  | 5 | 24 | 5 | 20 |  |
| tPZH | $\overline{\text { OEBA }}$ | A | 3 | 20 | 3 | 17 | ns |
| tpZL |  |  | 5 | 22 | 5 | 18 |  |
| tPHZ | $\overline{\text { OEBA }}$ | A | 1 | 12 | 1 | 10 | ns |
| tplZ |  |  | 2 | 20 | 2 | 16 |  |
| tPZH | OEAB | B | 8 | 25 | 3 | 22 | ns |
| tPZL |  |  | 6 | 21 | 5 | 18 |  |
| tPHZ | OEAB | B | 1 | 12 | 1 | 10 | ns |
| tPLZ |  |  | 2 | 21 | 2 | 16 |  |

$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
$\ddagger$ These parameters are measured with the internal output state of the storage register opposite that of the bus input.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

```
Supply voltage range, V VC . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . -0.5 V to 7 V
Input voltage range, V!: Control inputs . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . - 0.5 V to 7 V
    I/O ports ................................................................ . . . . . . . . . V to 5.5 V
```



```
    NT package . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 67*
Storage temperature range, T}\mp@subsup{T}{\mathrm{ stg }}{\mathrm{ . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . - -65*}
\(\dagger\) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.
```

recommended operating conditions

|  |  |  | SN54ALS653 |  |  | SN74ALS653 |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | NOM | MAX | MIN | NOM | MAX |  |
| $\mathrm{V}_{\text {CC }}$ | Supply voltage |  | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | High-level input voltage |  | 2 |  |  | 2 |  |  | V |
| $\mathrm{V}_{\text {IL }}$ | Low-level input voltage |  |  |  | 0.7 |  |  | 0.8 | V |
| $\mathrm{V}_{\mathrm{OH}}$ | High-level output voltage | A ports |  |  | 5.5 |  |  | 5.5 | V |
| ${ }^{\mathrm{I} \mathrm{OH}}$ | High-level output current | B ports |  |  | -12 |  |  | -15 | mA |
| IOL | Low-level output current |  |  |  | 12 |  |  | 24 | mA |
| ${ }^{\text {clock }}$ | Clock frequency |  | 0 |  | 25 | 0 |  | 35 | MHz |
| $\mathrm{t}_{\mathrm{w}}$ | Pulse duration | CLKBA or CLKAB high | 20 |  |  | 14.5 |  |  | ns |
|  |  | CLKBA or CLKAB low | 20 |  |  | 14.5 |  |  |  |
| $\mathrm{t}_{\text {su }}$ | Setup time before CLKAB $\uparrow$ or CLKBA $\uparrow$ | A or B | 15 |  |  | 10 |  |  | ns |
| th | Hold time after CLKAB $\uparrow$ or CLKBA $\uparrow$ | A or B | 5 |  |  | 0 |  |  | ns |
| $\mathrm{T}_{\text {A }}$ | Operating free-air temperature |  | -55 |  | 125 | 0 |  | 70 | ${ }^{\circ} \mathrm{C}$ |

## recommended operating conditions


electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | SN5 | 54ALS6 |  |  | 4ALS6 |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYP $\dagger$ | MAX | MIN | TYP $\dagger$ | MAX |  |
| $\mathrm{V}_{\text {IK }}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}=-18 \mathrm{~mA}$ |  |  | -1.2 |  |  | -1.2 | V |
| $\mathrm{V}_{\mathrm{OH}}$ | B ports | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to $5.5 \mathrm{~V}, \quad \mathrm{I}_{\mathrm{OH}}=-0.4 \mathrm{~mA}$ |  | $\mathrm{V}_{\mathrm{CC}}{ }^{-2}$ |  |  | $\mathrm{V}_{\mathrm{CC}}-2$ |  |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{IOH}=-3 \mathrm{~mA}$ | 2.4 | 3.2 |  | 2.4 | 3.2 |  |  |
|  |  |  | $\mathrm{IOH}=-12 \mathrm{~mA}$ | 2 |  |  |  |  |  |  |
|  |  |  | $\mathrm{I} \mathrm{OH}=-15 \mathrm{~mA}$ |  |  |  | 2 |  |  |  |
| VOL |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{IOL}=12 \mathrm{~mA}$ |  | 0.25 | 0.4 |  | 0.25 | 0.4 | V |
|  |  | $\mathrm{I}^{\mathrm{OL}}=24 \mathrm{~mA}$ |  |  |  |  | 0.35 | 0.5 |  |
| 1 | Control inputs |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=7 \mathrm{~V}$ |  |  | 0.1 |  |  | 0.1 | mA |
|  | A or B ports | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=5.5 \mathrm{~V}$ |  |  | 0.1 |  |  | 0.1 |  |  |
| ${ }^{1} \mathrm{H}$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=2.7 \mathrm{~V}$ |  |  | 20 |  |  | 20 | $\mu \mathrm{A}$ |  |
|  | A or B ports $\ddagger$ |  |  |  |  | 20 |  |  | 20 |  |  |
|  | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=0.4 \mathrm{~V}$ |  |  | -0.2 |  |  | -0.2 | mA |  |
| IL | A or B ports $\ddagger$ |  |  |  |  | -0.2 |  |  | -0.2 |  |  |
| ${ }^{\mathrm{O}} \mathrm{OH}$ | A ports | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{OH}}=5.5 \mathrm{~V}$ |  |  | 0.1 |  |  | 0.1 | mA |  |
| 10 § | B ports | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -20 |  | -112 | -30 |  | -112 | mA |  |
| ICC |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ | Outputs high |  | 47 | 76 |  | 47 | 76 | mA |  |
|  |  | Outputs low |  | 55 | 88 |  | 55 | 88 |  |  |
|  |  | Outputs disabled |  | 55 | 88 |  | 55 | 88 |  |  |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ For I/O ports, the parameters $\mathrm{I}_{\mathrm{IH}}$ and $\mathrm{I}_{\mathrm{IL}}$ include the off-state output current.
§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.
electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS |  | SN74ALS654 |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | TYPt | MAX |  |
| $\mathrm{V}_{\text {IK }}$ |  |  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{I}=-18 \mathrm{~mA}$ |  |  | -1.2 | V |
| V OH | B ports | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ to 5.5 V , | $1 \mathrm{OH}=-0.4 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{CC}}-2$ |  |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{IOH}=-3 \mathrm{~mA}$ | 2.4 | 3.2 |  |  |
|  |  |  | $\mathrm{I} \mathrm{OH}=-15 \mathrm{~mA}$ | 2 |  |  |  |
| VOL |  | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$ | $\mathrm{I} \mathrm{OL}=12 \mathrm{~mA}$ |  | 0.25 | 0.4 | V |
|  |  | $\mathrm{IOL}=24 \mathrm{~mA}$ |  | 0.35 | 0.5 |  |
| 1 | Control inputs |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=7 \mathrm{~V}$ |  |  | 0.1 | mA |
|  | A or B ports | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=5.5 \mathrm{~V}$ |  |  | 0.1 |  |  |
| ${ }^{1} \mathrm{H}$ | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=2.7 \mathrm{~V}$ |  |  | 20 | $\mu \mathrm{A}$ |  |
|  | A or B ports $\ddagger$ |  |  |  |  | 20 |  |  |
| IIL | Control inputs | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{I}}=0.4 \mathrm{~V}$ |  |  | -0.2 | mA |  |
|  | A or B ports $\ddagger$ |  |  |  |  | -0.2 |  |  |
| ${ }^{\mathrm{O}} \mathrm{OH}$ | A ports | $\mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{OH}}=5.5 \mathrm{~V}$ |  |  | 0.1 | mA |  |
| lo§ | B ports | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$, | $\mathrm{V}_{\mathrm{O}}=2.25 \mathrm{~V}$ | -30 |  | -112 | mA |  |
| ${ }^{\text {ICC }}$ |  | $\mathrm{V}_{\mathrm{CC}}=5.5 \mathrm{~V}$ | Outputs high |  | 47 | 76 | mA |  |
|  |  | Outputs low |  | 55 | 88 |  |  |
|  |  | Outputs disabled |  | 55 | 88 |  |  |

[^2]$\ddagger$ For I/O ports, the parameters $I_{I H}$ and $l_{I L}$ include the off-state output current.
§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.
switching characteristics (see Figure 2)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{array}{\|l} \hline \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ \mathrm{R}_{\mathrm{L}}=680 \Omega \text { (A outputs), } \\ \mathrm{R} 1=\mathrm{R} 2=500 \Omega \text { (B outputs), } \\ \mathrm{T}_{\mathrm{A}}=\text { MIN to MAX } \dagger \\ \hline \end{array}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54ALS653 |  | SN74ALS653 |  |  |
|  |  |  | MIN | MAX | MIN | MAX |  |
| ${ }_{\text {f max }}$ |  |  | 25 |  | 35 |  | MHz |
| tPLH | CLKBA | A | 16 | 71 | 16 | 64 | ns |
| tPHL |  |  | 6 | 24 | 6 | 22 |  |
| tPLH | CLKAB | B | 10 | 35 | 10 | 30 | ns |
| tPHL |  |  | 5 | 20 | 5 | 17 |  |
| tPLH | A | B | 5 | 20 | 5 | 18 | ns |
| tphL |  |  | 1.5 | 18 | 2 | 15 |  |
| tPLH | B | A | 8 | 63 | 12 | 56 | ns |
| tPHL |  |  | 2 | 18 | 2 | 15 |  |
| tPLH | SBA $\ddagger$ (with B high) | A | 12 | 68 | 19 | 62 | ns |
| tPHL |  |  | 5 | 27 | 5 | 25 |  |
| tPLH | $\begin{gathered} \text { SBA } \ddagger \\ \text { (with B low) } \end{gathered}$ | A | 12 | 68 | 19 | 62 | ns |
| tPHL |  |  | 5 | 27 | 5 | 25 |  |
| tPLH | SAB $\ddagger$ <br> (with A high) | B | 8 | 30 | 15 | 35 | ns |
| tPHL |  |  | 6 | 25 | 6 | 22 |  |
| tPLH | SAB $\ddagger$ (with A low) | B | 12 | 40 | 8 | 25 | ns |
| tPHL |  |  | 6 | 25 | 6 | 22 |  |
| tPLH | $\overline{\text { OEBA }}$ | A | 6 | 35 | 6 | 30 | ns |
| tPHL |  |  | 6 | 27 | 6 | 24 |  |
| tPZH | OEAB | B | 7 | 25 | 8 | 22 | ns |
| tPZL |  |  | 6 | 25 | 6 | 22 |  |
| tPHZ | OEAB | B | 1 | 16 | 1 | 14 | ns |
| tPLZ |  |  | 2 | 21 | 2 | 16 |  |

$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
$\ddagger$ These parameters are measured with the internal output state of the storage register opposite that of the bus input.
switching characteristics (see Figure 2)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R}_{\mathrm{L}}=680 \Omega \text { (A outputs), } \\ & \mathrm{R} 1=\mathrm{R} 2=500 \Omega \text { (B outputs), } \\ & \mathrm{T}_{\mathrm{A}}=\text { MIN to MAX } \dagger \\ & \hline \end{aligned}$ |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN74ALS654 |  |  |
|  |  |  | MIN | MAX |  |
| $\mathrm{f}_{\text {max }}$ |  |  | 35 |  | MHz |
| tPLH | CLKBA | A | 16 | 64 | ns |
| tPHL |  |  | 6 | 22 |  |
| tPLH | CLKAB | B | 10 | 30 | ns |
| tPHL |  |  | 5 | 17 |  |
| tPLH | A | B | 5 | 18 | ns |
| tPHL |  |  | 2 | 15 |  |
| tPLH | B | A | 12 | 56 | ns |
| tPHL |  |  | 2 | 21 |  |
| tPLH | SBA $\ddagger$ (with B low) | A | 19 | 62 | ns |
| tPHL |  |  | 5 | 25 |  |
| tPLH | SBA $\ddagger$ <br> (with B high) | A | 19 | 62 | ns |
| tphL |  |  | 5 | 25 |  |
| tPLH | SAB $\ddagger$ (with A low) | B | 15 | 35 | ns |
| tPHL |  |  | 6 | 22 |  |
| tPLH | SAB $\ddagger$ <br> (with A high) | B | 8 | 25 | ns |
| tPHL |  |  | 6 | 22 |  |
| tPLH | $\overline{O E B A}$ | A | 6 | 30 | ns |
| tPHL |  |  | 6 | 24 |  |
| tPZH | OEAB | B | 6 | 22 | ns |
| tPZL |  |  | 6 | 22 |  |
| tPHZ | OEAB | B | 1 | 14 | ns |
| tPLZ |  |  | 2 | 16 |  |

$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
$\ddagger$ These parameters are measured with the internal output state of the storage register opposite that of the bus input.

# SN54ALS652, SN54ALS653, SN54AS651, SN54AS652 SN74ALS651A, SN74ALS652A, SN74ALS653, SN74ALS654, SN74AS651, SN74AS652 OCTAL BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS 

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

$$
\begin{aligned}
& \text { Supply voltage range, } \mathrm{V}_{\mathrm{CC}} \\
& -0.5 \mathrm{~V} \text { to } 7 \mathrm{~V} \\
& \text { Input voltage range, } \mathrm{V}_{\mathrm{F}} \text { : Control inputs . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . } 0.5 \mathrm{~V} \text { to } 7 \mathrm{~V} \\
& \text { I/O ports . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . } 0.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V} \\
& \text { Package thermal impedance, } \theta_{\text {JA }} \text { (see Note 1): DW package . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 46} \mathrm{C} / \mathrm{W} \\
& \text { NT package } \\
& 67^{\circ} \mathrm{C} / \mathrm{W} \\
& \text { Storage temperature range, } \mathrm{T}_{\text {stg }} \\
& -65^{\circ} \mathrm{C} \text { to } 150^{\circ} \mathrm{C} \\
& \dagger \text { Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and } \\
& \text { functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not } \\
& \text { implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. } \\
& \text { NOTE 1: The package thermal impedance is calculated in accordance with JESD } 51
\end{aligned}
$$

recommended operating conditions

|  |  |  | SN54AS651 <br> SN54AS652 |  |  | $\begin{aligned} & \text { SN74AS651 } \\ & \text { SN74AS652 } \end{aligned}$ |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | NOM | MAX | MIN | NOM | MAX |  |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage |  | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| $\mathrm{V}_{\text {IH }}$ | High-level input voltage |  | 2 |  |  | 2 |  |  | V |
| $\mathrm{V}_{\text {IL }}$ | Low-level input voltage |  |  |  | 0.8 |  |  | 0.8 | V |
| ${ }^{\mathrm{OH}}$ | High-level output current |  |  |  | -12 |  |  | -15 | mA |
| l OL | Low-level output current |  |  |  | 32 |  |  | 48 | mA |
| ${ }^{\text {f clock }}$ | Clock frequency |  | 0* |  | 75* | 0 |  | 90 | MHz |
| $\mathrm{t}_{\mathrm{w}}$ | Pulse duration | CLKBA or CLKAB high | 6* |  |  | 5 |  |  | ns |
|  |  | CLKBA or CLKAB low | 7* |  |  | 6 |  |  |  |
| $\mathrm{t}_{\text {su }}$ | Setup time before CLKAB $\uparrow$ or CLKBA $\uparrow$ | A or B | 7* |  |  | 6 |  |  | ns |
| $t_{\text {h }}$ | Hold time after CLKAB $\uparrow$ or CLKBA | A or B | 0* |  |  | 0 |  |  | ns |
| $\mathrm{T}_{\text {A }}$ | Operating free-air temperature |  | -55 |  | 125 | 0 |  | 70 | ${ }^{\circ} \mathrm{C}$ |

* On products compliant to MIL-PRF-38535, this parameter is based on characterized data but is not production tested.
electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ For I/O ports, the parameters $\mathrm{l}_{\mathrm{IH}}$ and $\mathrm{l}_{\mathrm{IL}}$ include the off-state output current.
§ The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.
switching characteristics (see Figure 2)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R} 1=500 \Omega, \\ & \mathrm{R} 2=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAX } \dagger \end{aligned}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54AS651 |  | SN74AS651 |  |  |
|  |  |  | MIN | MAX | MIN | MAX |  |
| $f_{\text {max }}$ |  |  | 75* |  | 90 |  | MHz |
| tPLH | CLKBA or CLKAB | A or B | 2 | 11 | 2 | 8.5 | ns |
| tPHL |  |  | 2 | 10 | 2 | 9 |  |
| tPLH | A or B | B or A | 2 | 12 | 2 | 8 | ns |
| tPHL |  |  | 1 | 8 | 1 | 7 |  |
| tPLH | SBA or SAB $\ddagger$ | A or B | 2 | 15 | 2 | 11 | ns |
| tPHL |  |  | 2 | 11 | 2 | 9 |  |
| tPZH | $\overline{\text { OEBA }}$ | A | 2 | 11 | 2 | 10 | ns |
| tPZL |  |  | 3 | 18 | 3 | 16 |  |
| tPHZ | $\overline{\text { OEBA }}$ | A | 2 | 10 | 2 | 9 | ns |
| tPLZ |  |  | 2 | 10 | 2 | 9 |  |
| tPZH | OEAB | B | 3 | 12 | 3 | 11 | ns |
| tPZL |  |  | 3 | 20 | 3 | 16 |  |
| tPHZ | OEAB | B | 2 | 11 | 2 | 10 | ns |
| tPLZ |  |  | 2 | 12 | 2 | 11 |  |

[^3]
## switching characteristics (see Figure 2)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{gathered} \hline \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { TO } 5.5 \mathrm{~V}, \\ \mathrm{C}_{\mathrm{L}}=50 \mathrm{PF}, \\ \mathrm{R} 1=500 \Omega, \\ \mathrm{R} 2=500 \Omega, \\ \mathrm{~T}_{\mathrm{A}}=\mathrm{MIN} \text { TO MAXt } \end{gathered}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54AS652 |  | SN74AS652 |  |  |
|  |  |  | MIN | MAX | TYP | MAX |  |
| $f_{\text {max }}$ |  |  | 75* |  | 90 |  | MHz |
| tPLH | CLKBA or CLKAB | A or B | 2 | 11 | 2 | 8.5 | ns |
| tPHL |  |  | 2 | 10 | 2 | 9 |  |
| tPLH | A or B | B or A | 2 | 12 | 2 | 9 | ns |
| tPHL |  |  | 1 | 8 | 1 | 7 |  |
| tPLH | SBA or SAB $\ddagger$ | A or B | 2 | 15 | 2 | 11 | ns |
| tPHL |  |  | 2 | 11 | 2 | 9 |  |
| tPZH | $\overline{O E B A}$ | A | 2 | 11 | 2 | 10 | ns |
| tPZL |  |  | 3 | 18 | 3 | 16 |  |
| tPHZ | $\overline{\text { OEBA }}$ | A | 2 | 10 | 2 | 9 | ns |
| tpLZ |  |  | 2 | 10 | 2 | 9 |  |
| tPZH | OEAB | B | 3 | 12 | 3 | 11 | ns |
| tPZL |  |  | 3 | 20 | 3 | 16 |  |
| tPHZ | OEAB | B | 2 | 11 | 2 | 10 | ns |
| tpLZ |  |  | 2 | 12 | 2 | 11 |  |

* On products compliant to MIL-PRF-38535, this parameter is based on characterized data but is not production tested.
$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
$\ddagger$ These parameters are measured with the internal output state of the storage register opposite that of the bus input.


## PARAMETER MEASUREMENT INFORMATION



LOAD CIRCUIT FOR 3-STATE OUTPUTS


VOLTAGE WAVEFORMS SETUP AND HOLD TIMES


VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES

SWITCH POSITION TABLE

| TEST | S1 |
| :---: | :---: |
| tPLH | Open |
| tPHL | Open |
| tPZH | Open |
| tPZL | Closed |
| tPHZ | Open |
| tPLZ | Closed |



VOLTAGE WAVEFORMS PULSE DURATION


VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS

NOTES: A. $\mathrm{C}_{\mathrm{L}}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}} \leq 2 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 2 \mathrm{~ns}$.
D. The outputs are measured one at a time with one transition per measurement.

Figure 2. Load Circuits and Voltage Waveforms

TEXAS
PACKAGE OPTION ADDENDUM
INSTRUMENTS

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 5962-88673013A | ACTIVE | LCCC | FK | 28 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & 5962- \\ & 88673013 A \\ & \text { SNJ54ALS } \\ & \text { 652FK } \end{aligned}$ | Samples |
| 5962-8867301LA | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | 5962-8867301LA SNJ54ALS652JT | Samples |
| 5962-8868701LA | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | 5962-8868701LA SNJ54AS652JT | Samples |
| 5962-89687013A | ACTIVE | LCCC | FK | 28 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & \hline 5962- \\ & \text { 89687013A } \\ & \text { SNJ54ALS } \\ & \text { 653FK } \end{aligned}$ | Samples |
| 5962-8968701LA | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | 5962-8968701LA SNJ54ALS653JT | Samples |
| SN54ALS652JT | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | SN54ALS652JT | Samples |
| SN54AS652JT | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | SN54AS652JT | Samples |
| SN74ALS652A-1DW | ACTIVE | SOIC | DW | 24 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | ALS652A-1 | Samples |
| SN74ALS652ADW | ACTIVE | SOIC | DW | 24 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | ALS652A | Samples |
| SN74ALS652ADWR | ACTIVE | SOIC | DW | 24 | 2000 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | ALS652A | Samples |
| SN74ALS653DW | ACTIVE | SOIC | DW | 24 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | ALS653 | Samples |
| SN74ALS653DWE4 | ACTIVE | SOIC | DW | 24 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | ALS653 | Samples |
| SN74ALS654DW | ACTIVE | SOIC | DW | 24 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | ALS654 | Samples |
| SN74AS652DW | ACTIVE | SOIC | DW | 24 | 25 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | AS652 | Samples |
| SNJ54ALS652FK | ACTIVE | LCCC | FK | 28 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & \text { 5962- } \\ & \text { 88673013A } \\ & \text { SNJ54ALS } \\ & \text { 652FK } \end{aligned}$ | Samples |

INSTRUMENTS

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SNJ54ALS652JT | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & \text { 5962-8867301LA } \\ & \text { SNJ54ALS652JT } \end{aligned}$ | Samples |
| SNJ54ALS653FK | ACTIVE | LCCC | FK | 28 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & \text { 5962- } \\ & \text { 89687013A } \\ & \text { SNJ54ALS } \\ & 653 F K \end{aligned}$ | Samples |
| SNJ54ALS653JT | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | 5962-8968701LA SNJ54ALS653JT | Samples |
| SNJ54AS652JT | ACTIVE | CDIP | JT | 24 | 1 | Non-RoHS \& Green | SNPB | N / A for Pkg Type | -55 to 125 | 5962-8868701LA SNJ54AS652JT | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free"
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption
Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of $<=1000 \mathrm{ppm}$ threshold. Antimony trioxide based flame retardants must also meet the $<=1000 \mathrm{ppm}$ threshold requirement
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54ALS653, SN54AS652, SN74ALS653, SN74AS652 :

- Catalog : SN74ALS653, SN74AS652
- Military : SN54ALS653, SN54AS652

NOTE: Qualified Version Definitions

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

TeXAS

## TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> $\mathbf{W 1}(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74ALS652ADWR | SOIC | DW | 24 | 2000 | 330.0 | 24.4 | 10.75 | 15.7 | 2.7 | 12.0 | 24.0 | Q1 |

PACKAGE MATERIALS INFORMATION

*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length $(\mathbf{m m})$ | Width $(\mathbf{m m})$ | Height $(\mathrm{mm})$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74ALS652ADWR | SOIC | DW | 24 | 2000 | 350.0 | 350.0 | 43.0 |

## TUBE



## B - Alignment groove width

*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W $(\mathbf{m m})$ | T $(\boldsymbol{\mu m})$ | B (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SN74ALS652A-1DW | DW | SOIC | 24 | 25 | 506.98 | 12.7 | 4826 | 6.6 |
| SN74ALS652ADW | DW | SOIC | 24 | 25 | 506.98 | 12.7 | 4826 | 6.6 |
| SN74ALS653DW | DW | SOIC | 24 | 25 | 506.98 | 12.7 | 4826 | 6.6 |
| SN74ALS653DWE4 | DW | SOIC | 24 | 25 | 506.98 | 12.7 | 4826 | 6.6 |
| SN74ALS654DW | DW | SOIC | 24 | 25 | 506.98 | 12.7 | 4826 | 6.6 |
| SN74AS652DW | DW | SOIC | 24 | 25 | 506.98 | 12.7 | 4826 | 6.6 |



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification.
E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB

FK (S-CQCC-N**)
LEADLESS CERAMIC CHIP CARRIER 28 TERMINAL SHOWN


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a metal lid.
D. Falls within JEDEC MS-004

DW (R-PDSO-G24) PLASTIC SMALL OUTLINE


NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed $0.006(0,15)$.
D. Falls within JEDEC MS-013 variation AD.

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[^0]:    $\ddagger$ Applies only to the SN74ALS652A-1 and only if $\mathrm{V}_{\mathrm{CC}}$ is maintained between 4.75 V and 5.25 V

[^1]:    $\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

[^2]:    $\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

[^3]:    * On products compliant to MIL-PRF-38535, this parameter is based on characterized data but is not production tested.
    $\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
    $\ddagger$ These parameters are measured with the internal output state of the storage register opposite that of the bus input.

